IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant	:	Tetsuya MAKIMURAI, et al.) Group Art Unit Unknown
Int'l App. No.	:	PCT/JP2005/001886)
Int'l Filing Date	:	February 9, 2005)
For	:	SOFT X-RAY PROCESSING DEVICE AND SOFT X-RAY PROCESSING METHOD))))
Examiner	:	Unknown	<i>`</i>

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Enclosed is form PTO/SB/08 Equivalent listing references that are also enclosed. As indicated in the accompanying Form PCT/ISA/210, all documents except US 6,818,908, JP 2002-252258 and JP 2003-167354 were cited in the International Search Report in the international phase of the present U.S. national phase application. Although the listed references are already of record during the International Phase of the application, they are submitted in the present Information Disclosure Statement for the convenience of the Examiner and to ensure that the references are listed on the cover of any patent issued on the present application.

Document No. US 6,818,908, JP 2002-252258 and JP 2003-167354 are additional references that are not previously cited during the International Phase, but they are relevant to the present patent application since they disclose the information indicated in the publications. This Information Disclosure Statement is being filed within three months of the date of entry of the national stage of this application, and no fee is required in accordance with 37 C.F.R. § 1.97(b)(2).

Respectfully submitted, KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: August 10, 2006 By: William Katsuhiro Arai

Registration No. 43,315 Attorney of Record Customer No. 20,995 (949) 760-0404

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Multiple sheets used when necessary) Infl Application No. Infl Filing Date February 9, 2005 First Named Inventor Art Unit Chitarown 2882 Examiner Chitarown Allen C. Ho

SHEET 1 OF 1

			U.S. PATENT	DOCUMENTS	
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
/ACH/	1.	4,525,853	06/25/1985	Keem, et al.	
/ACH/	2.	6,818,908 B2	11/16/2004	Makimura	

Attorney Docket No.

MITPA14.001APC

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
/ACH/	3.	JP 08-005796	01/12/1996	Hitachi Ltd.	(English Abstract Only)	Х
/ACH/	4.	JP 08-271697	10/18/1996	Canon Inc.	(English Abstract Only)	Х
/ACH/	5.	JP 11-026199	01/29/1999	Mitsubishi Electric Corp	(English Abstract Only)	Х
/ACH/	6.	JP 11-064595	03/05/1999	Rigaku Ind Co.	(English Abstract Only)	Х
/ACH/	7.	JP 2001-068296	03/16/2001	Institute of Tsukuba Liaison Co Ltd	(English Abstract Only)	Х
/ACH/	8.	JP 2002-252258	JP 2002-252258 09/06/2002 Hoya Corp (English Abstract Only)		(English Abstract Only)	Х
/ACH/	9.	JP 2003-014895	01/15/2003	Rigaku Corp	(English Abstract Only)	Х
/ACH/	10.	JP 2003-167354	06/13/2003	Tetsuya Makimura	(English Abstract Only)	х

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serfal, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹	

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Examiner Signature /Allen C. Ho/ Date Considered 08/28/2008

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.